

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/813,667	LEE ET AL.
Examiner	Art Unit	
		2128

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
UPDATE: IEEE Xplore	2.21.06	RF
Inspec Dialog Acm Dig. Lib.		
ScienceDirect ProQuest		
WEST	.	.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
703	22,23	2.21.06	RF
718	104		
709	203		
9	226		